

Search Notes**Application/Control No.**

10/706,530

Applicant(s)/Patent under Reexamination

SETH ET AL.

Examiner

Mark Eashoo, Ph.D.

Art Unit

1732

SEARCHED

Class	Subclass	Date	Examiner
428	100		
24	452		
264	145		
	167		
	156		
	288.4		
	288.8		
	342e		
	211.17	6/2/2005	ME
<i>Abner Sonnen</i> <i>SEARCH UPATED</i>		10/31/05	ME
<i>Abner Sonnen</i> <i>SEARCH UPATED</i>		27/Jan/06	ME

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search (eDAN)	6/2/2005	ME
<i>SEARCH UPATED</i>	11/27/06	ME